

Level 3 Condensed Matter Physics- Part II
Weekly problem 1 solutions

(1) The lattice constant for InP is 5.87 Å. We want to find x such that $a(\text{Ga}_x\text{In}_{1-x}\text{As}) = 5.87 \text{ Å}$.

$$\begin{aligned} a(\text{Ga}_x\text{In}_{1-x}\text{As}) &= xa(\text{GaAs}) + (1-x)a(\text{InAs}) \\ 5.87 \text{ Å} &= x5.65\text{Å} + (1-x)6.06\text{Å} \\ x &= 0.46 \end{aligned}$$

[2 marks]

The energy gap at this composition is:

$$\begin{aligned} E_g(\text{Ga}_x\text{In}_{1-x}\text{As}) &= xE_g(\text{GaAs}) + (1-x)E_g(\text{InAs}) - bx(1-x) \\ &= 0.73 \text{ eV} \end{aligned}$$

[2 marks]

(2) We first express the energy of the conduction electron in the following manner:

$$E(k_x, k_y) = (A+B)k_x^2 + Ak_y^2$$

From the definition of the effective mass tensor $(m^*)_{ij} = \hbar^2/(d^2E/dk_i dk_j)$ it follows that:

$$(m^*)_{xx} = \hbar^2/2(A+B)$$

[2 marks]

$$(m^*)_{yy} = \hbar^2/2A$$

[2 marks]

(3) The fractional atom coordinates for a fcc lattice is $[0,0,0]$, $[\frac{1}{2}, \frac{1}{2}, 0]$, $[\frac{1}{2}, 0, \frac{1}{2}]$ and $[0, \frac{1}{2}, \frac{1}{2}]$. Adding the $[\frac{1}{4}, \frac{1}{4}, \frac{1}{4}]$ vector gives the other four atom positions, i.e. $[\frac{1}{4}, \frac{1}{4}, \frac{1}{4}]$, $[\frac{3}{4}, \frac{3}{4}, \frac{1}{4}]$, $[\frac{3}{4}, \frac{1}{4}, \frac{3}{4}]$ and $[\frac{1}{4}, \frac{3}{4}, \frac{3}{4}]$.

[2 marks]

Level 3 Condensed Matter Physics- Part II
Weekly problem 2 solutions

(1) i) The donor ionisation energy is given by [1 mark]

$$E_D = \frac{e^4 m_e^*}{2(4\pi\epsilon\epsilon_0\hbar)^2} = \frac{m_e^*}{m\epsilon^2} \left[\frac{e^4 m}{2(4\pi\epsilon_0\hbar)^2} \right]$$

$$= \frac{0.2}{(11.7)^2} \times 13.6 \text{ eV} = 19.9 \text{ meV}$$

ii) The radius of the orbit [1 mark]

$$r = \frac{4\pi\epsilon\epsilon_0\hbar^2}{m_e^* e^2} = \frac{\epsilon m}{m_e^*} \left(\frac{4\pi\epsilon_0\hbar^2}{m e^2} \right)$$

$$= \frac{11.7}{0.2} \times 0.53 \text{ Å} = 31.0 \text{ Å}$$

iii) The overlap occurs when [1 mark]

$$N_D \sim \frac{1}{\frac{4}{3}\pi r^3} = 8.0 \times 10^{24} \text{ m}^{-3}$$

(2) For an intrinsic semiconductor:

$$n = \sqrt{N_c N_v} \exp\left(-\frac{E_g}{2kT}\right)$$

so that

$$\frac{n(T)}{n(300K)} = \exp\left[-\frac{E_g}{2k}\left(\frac{1}{T} - \frac{1}{300}\right)\right]$$

[1 mark]

Extrinsic behaviour occurs when $n(T) \leq 10^{18} \text{ m}^{-3}$ [1 mark]. Substituting into the above equation:

$$\frac{10^{18}}{5 \times 10^{15}} = \exp\left[-\frac{E_g}{2k}\left(\frac{1}{T} - \frac{1}{300}\right)\right]$$

we have $T \leq 400 \text{ K}$. [2 marks]

(3) Since the semiconductor is in the saturation regime all phosphorus donor atoms are ionised and we assume the conductivity is dominated by the majority carrier electrons. [1 mark]

From $\sigma = en\mu_e$ with $n \sim 10^{20} \text{ m}^{-3}$ and $\mu_e = 0.16 \text{ m}^2\text{V}^{-1}\text{s}^{-1}$ we get $\sigma = 2.56 \text{ S/m}$. [2 marks]

Level 3 Condensed Matter Physics- Part II

Weekly problem 3 solutions

(1) i) The intrinsic carrier concentration (n_i) is given by [1 mark]:

$$n_i = \sqrt{N_c N_v} \exp\left(-\frac{E_g}{2kT}\right) = 9.7 \times 10^{15} \text{ m}^{-3}$$

The built-in voltage (V_{bi}) is therefore [1 mark]:

$$\phi_{bi} = \frac{kT}{e} \ln\left(\frac{N_A N_D}{n_i^2}\right) = 0.71 \text{ V}$$

ii) The space charge width on the n -side [1 mark]:

$$w_n = \left[\frac{2\epsilon_r \epsilon_0 \phi_{bi}}{e} \left(\frac{N_A}{N_D} \right) \left(\frac{1}{N_A + N_D} \right) \right]^{1/2} = 0.38 \text{ } \mu\text{m}$$

and on the p -side [1 mark]:

$$w_p = \left[\frac{2\epsilon_r \epsilon_0 \phi_{bi}}{e} \left(\frac{N_D}{N_A} \right) \left(\frac{1}{N_A + N_D} \right) \right]^{1/2} = 0.12 \text{ } \mu\text{m}$$

iii) The magnitude of the maximum electric field is [1 mark]:

$$\mathcal{E}_{\max} = \frac{e N_D w_n}{\epsilon_r \epsilon_0} = \frac{e N_A w_p}{\epsilon_r \epsilon_0} = 2.9 \times 10^6 \text{ V/m}$$

(2) The charge Q stored per unit junction area is:

$$Q = e N_A w_p = e N_D w_n = 3.0 \times 10^{-4} \text{ C/m}^2$$

The capacitance per unit area is therefore $C = Q/\phi_{bi} = 4.3 \times 10^{-4} \text{ F/m}^2$. [2 marks]

An alternative, but equivalent, definition of capacitance per unit area is:

$$C = \frac{\epsilon_r \epsilon_0}{d}$$

where d is the capacitor plate spacing. Substituting $d = (w_n + w_p)$ gives $C = 2.1 \times 10^{-4} \text{ F/m}^2$. This is different by a factor of 2 to the previous answer due to the approximate nature of the calculation. Both approaches are nevertheless acceptable. [2 marks]

(3) The current is given by [1 mark]:

$$I(V) = I_0 \left[\exp\left(\frac{eV}{kT}\right) - 1 \right]$$

Substituting $I = 25 \text{ mA}$ for 0.2 V forward bias gives $I_0 = 11 \text{ }\mu\text{A}$ [2 marks].

Level 3 Condensed Matter Physics- Part II

Weekly problem 4 solutions

(1) The change in the current (ΔI) cannot be larger than the precision of the measurement and therefore $\Delta I = I(t) - I_0 = -0.001I_0$, where I_0 is the current at $t = 0$ [1 mark].

Using $I(t) = I_0 \exp(-t/\tau)$:

$$\Delta I = I_0 \left[\exp\left(-\frac{t}{\tau}\right) - 1 \right] = -0.001I_0$$

Substituting $t = 1$ year gives $\tau = 999$ years. This is a lower limit for the average scattering time. [2 marks]

(2) For a Type I superconductor:

$$B_c(T) = B_c(0) \left[1 - \left(\frac{T}{T_c} \right)^2 \right]$$

[1 mark]

Substituting $T = 4.2$ K, $T_c = 7.2$ K and $B_c(0) = 0.080$ T gives $B_c(T = 4.2 \text{ K}) = 0.053$ T. [1 mark]

The maximum current is:

$$I_{max} = \frac{2\pi R B_c(T)}{\mu_0} = \frac{2\pi \times (0.5 \times 10^{-3} \text{ m}) \times 0.053 \text{ T}}{4\pi \times 10^{-7} \text{ H/m}} = 132.5 \text{ A}$$

[2 marks]

(3) The superconducting phase (beyond the London penetration depth) is a perfect diamagnet and has susceptibility -1. [1 mark]

If the volume fraction of superconducting and normal phase is V_{sc} and V_n respectively, with $V_{sc} + V_n = 1$, then:

$$\chi = -V_{sc} + (2 \times 10^{-5})V_n = -0.7$$

Solving for V_n gives $V_n = 0.3$ (30%) and hence $V_{sc} = 0.7$ (70%). [2 marks]